

FCC TEST REPORT
for
Anker Technology Co., Limited

Backlit Bluetooth Keyboard Case for iPad Air 2
Model No.: A7751

Prepared for : Anker Technology Co., Limited
Address : Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok,
Kowloon, Hongkong

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited
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Report Number : R011508392I
Date of Test : Aug. 17~ Sept. 16, 2015
Date of Report : Sept. 16, 2015

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TEST REPORT

Applicant : Anker Technology Co., Limited
Manufacturer : Anker Technology Co., Limited
EUT : Backlit Bluetooth Keyboard Case for iPad Air 2
Model No. : A7751
Serial No. : N.A.
Trade Mark : **ANKER**
Rating : DC 5V, 350mA

Measurement Procedure Used:

FCC Part15 Subpart C 2014, Paragraph 15.207, 15.247 & 15.209

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without

written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test : Aug. 17~ Sept. 16, 2015

Prepared by : (Tested Engineer / Kebo Zhang)

Reviewer : (Project Manager / Amy Ding)

Approved & Authorized Signer : (Manager / Tom Chen)

1. GENERAL INFORMATION

1.1 Description of Device (EUT)

EUT : Backlit Bluetooth Keyboard Case for iPad Air 2

Model Number : A7751

Test Power Supply : AC 120V, 60Hz for adapter/
AC 240V, 60Hz for adapter/
DC 3.7V Battery inside

Frequency : 2402~2480MHz

Antenna Specification : PCB Antenna: 1.87dBi

Modulation : GFSK, $\pi/4$ DQPSK, 8DPSK

Applicant Address : Anker Technology Co., Limited
: Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok,
Kowloon, Hongkong

Manufacturer Address : Anker Technology Co., Limited
: Room 1318-19, Hollywood Plaza, 610 Nathan Road, Mongkok,
Kowloon, Hongkong

Factory Address : Shenzhen Hastech Industries Co., Ltd.
: 3/F & 4/F, G-A1 BLDG, Democracy West Isdustry Park, Shajing
Town, Baoan District, Shenzhen, China

Date of receipt : Aug. 17, 2015

Date of Test : Aug. 17~ Sept. 16, 2015

1.2 Auxiliary Equipment Used during Test

Adapter : Manufacturer: Samsung
M/N: ETA-U90CBC
S/N: RT6FB17ZS/B-E
Input: AC 100-240V, 50-60Hz, 0.35A
Output: DC 5V, 2A

1.3 Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS - LAB Code: L3503

Shenzhen Anbotek Compliance Laboratory Limited., Laboratory has been assessed and in compliance with CNAS/CL01: 2006 accreditation criteria for testing laboratories (identical to ISO/IEC 17025:2005 General Requirements) for the Competence of Testing Laboratories.

FCC-Registration No.: 752021

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 752021, July 10, 2013.

IC-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited., EMC Laboratory has been registered and fully described in a report filed with the (IC) Industry Canada. The acceptance letter from the IC is maintained in our files. Registration 8058A, February 22, 2013.

Test Location

All Emissions tests were performed at

Shenzhen Anbotek Compliance Laboratory Limited. at 1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District, Shenzhen, Guangdong, China

1.4 Measurement Uncertainty

Radiation Uncertainty : Ur = 4.1 dB (Horizontal)
Ur = 4.3 dB (Vertical)

Conduction Uncertainty : Uc = 3.4dB

2. Test Procedure

GENERAL: This report shall NOT be reproduced except in full without the written approval of Shenzhen Anbotek Compliance Laboratory Limited. The EUT was transmitting a test signal during the testing.

RADIATION INTERFERENCE: The test procedure used was ANSI STANDARD C63.10-2013 using a spectrum analyzer with a pre-selector. The analyzer was calibrated in dB above a microvolt at the output of the antenna. The resolution bandwidth was 100KHz and the video bandwidth was 300KHz up to 1.0GHz and 1.0MHz with a video BW of 3.0MHz above 1.0GHz. The ambient temperature of the EUT was 74.3oF with a humidity of 69%.

FORMULA OF CONVERSION FACTORS: The Field Strength at 3m was established by adding the meter reading of the spectrum analyzer (which is set to read in units of dBuV) to the antenna correction factor supplied by the antenna manufacturer. The antenna correction factors are stated in terms of dB. The gain of the Preselector was accounted for in the Spectrum Analyzer Meter Reading.

Example:

$$\begin{aligned} \text{Freq (MHz) METER READING + ACF} &= \text{FS} \\ 20 \text{ dBuV} + 10.36 \text{ dB} &= 30.36 \text{ dBuV/m @ 3m} \end{aligned}$$

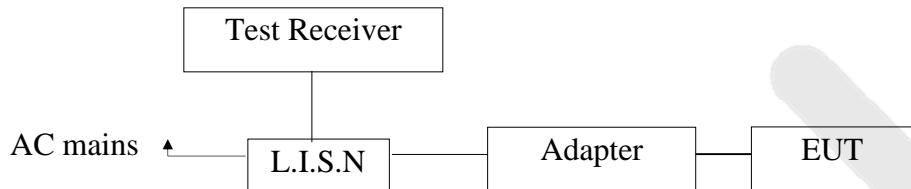
ANSI STANDARD C63.10-2013 10.1.7 MEASUREMENT PROCEDURES: The EUT was placed on a table 80 cm high and with dimensions of 1m by 1.5m. The EUT was placed in the center of the table (1.5m side). The table used for radiated measurements is capable of continuous rotation.

When an emission was found, the table was rotated to produce the maximum signal strength. At this point, the antenna was raised and lowered from 1m to 4m. The antenna was placed in both the horizontal and vertical planes.

3. Conducted Emission

3.1 Block Diagram of Test Setup

3.1.1. Block diagram of connection between the EUT and simulators



3.2 Power Line Conducted Emission Measurement Limits (15.207)

Frequency MHz	Limits dB(μ V)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.
 2. The lower limit shall apply at the transition frequencies.

3.3 Configuration of EUT on Measurement

The following equipments are installed on Power Line Conducted Emission Measurement to meet the commission requirement and operating regulations in a manner which tends to maximize its emission characteristics in a normal application.

3.4 Operating Condition of EUT

- 3.4.1. Setup the EUT and simulator as shown as Section 3.1.
- 3.4.2. Turn on the power of all equipment.
- 3.4.3. Let the EUT work in test mode (BT Mode and Charging) and measure it.

3.5 Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9KHz.

The frequency range from 150KHz to 30MHz is checked.

The test results are reported on Section 3.6.

Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Two-Line V-network	Rohde & Schwarz	ENV216	100055	Apr. 17, 2015	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Apr. 17, 2015	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Apr. 17, 2015	1 Year

3.6 Power Line Conducted Emission Measurement Results

PASS.

The frequency range from 150KHz to 30 MHz is investigated.

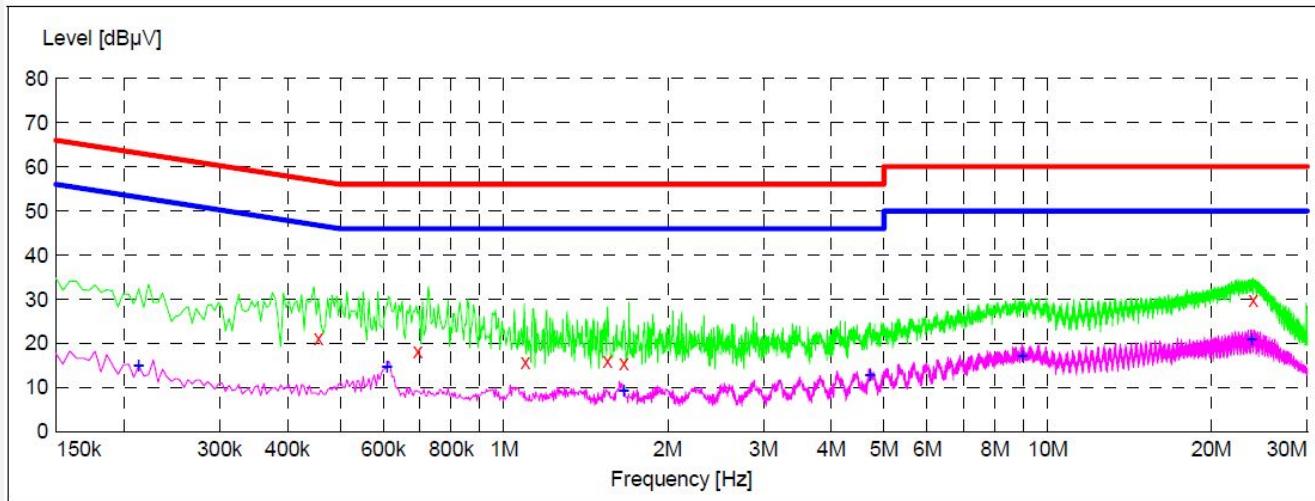
Please refer the following pages.

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: BT Mode and Charging
 Test Specification: AC 120V, 60Hz for adapter
 Comment: Live Line
 Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.456000	21.20	20.1	57	35.6	QP	L1	GND
0.694500	18.30	20.1	56	37.7	QP	L1	GND
1.094500	15.90	20.2	56	40.1	QP	L1	GND
1.549000	16.10	20.3	56	39.9	QP	L1	GND
1.661500	15.60	20.3	56	40.4	QP	L1	GND
23.882500	30.00	20.8	60	30.0	QP	L1	GND

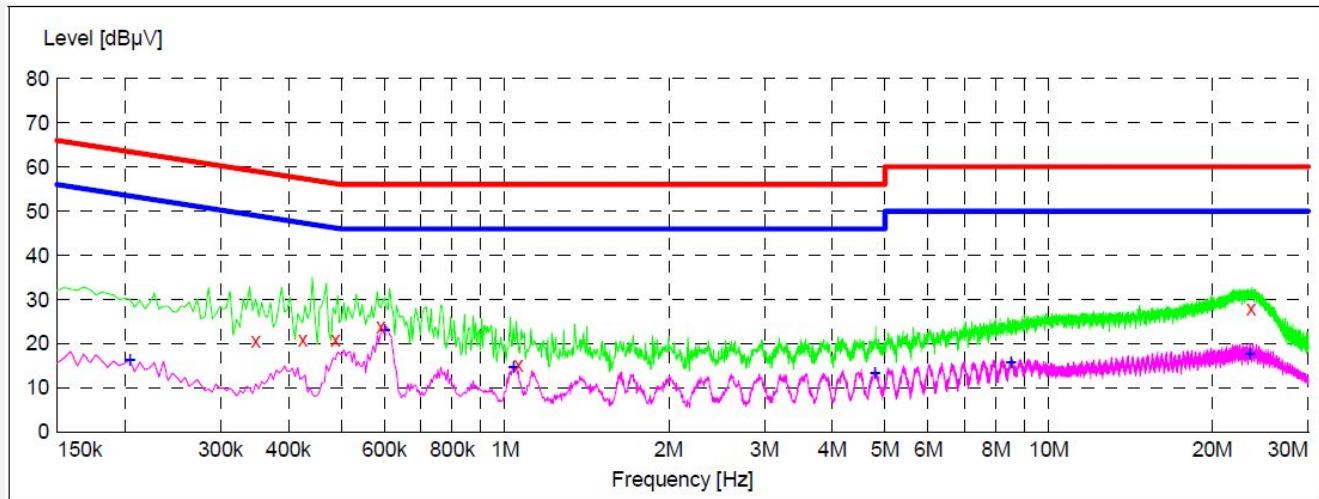
Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.213000	14.90	20.1	53	38.2	AV	L1	GND
0.609000	14.80	20.1	46	31.2	AV	L1	GND
1.661500	9.40	20.3	46	36.6	AV	L1	GND
4.708000	12.90	20.5	46	33.1	AV	L1	GND
8.983000	17.10	20.6	50	32.9	AV	L1	GND
23.716000	21.00	20.8	50	29.0	AV	L1	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: BT Mode and Charging
 Test Specification: AC 120V, 60Hz for adapter
 Comment: Neutral Line
 Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.348000	20.70	20.1	59	38.3	QP	N	GND
0.424500	20.90	20.1	57	36.5	QP	N	GND
0.487500	21.00	20.1	56	35.2	QP	N	GND
0.591000	23.90	20.1	56	32.1	QP	N	GND
1.058500	15.40	20.2	56	40.6	QP	N	GND
23.554000	28.10	20.8	60	31.9	QP	N	GND

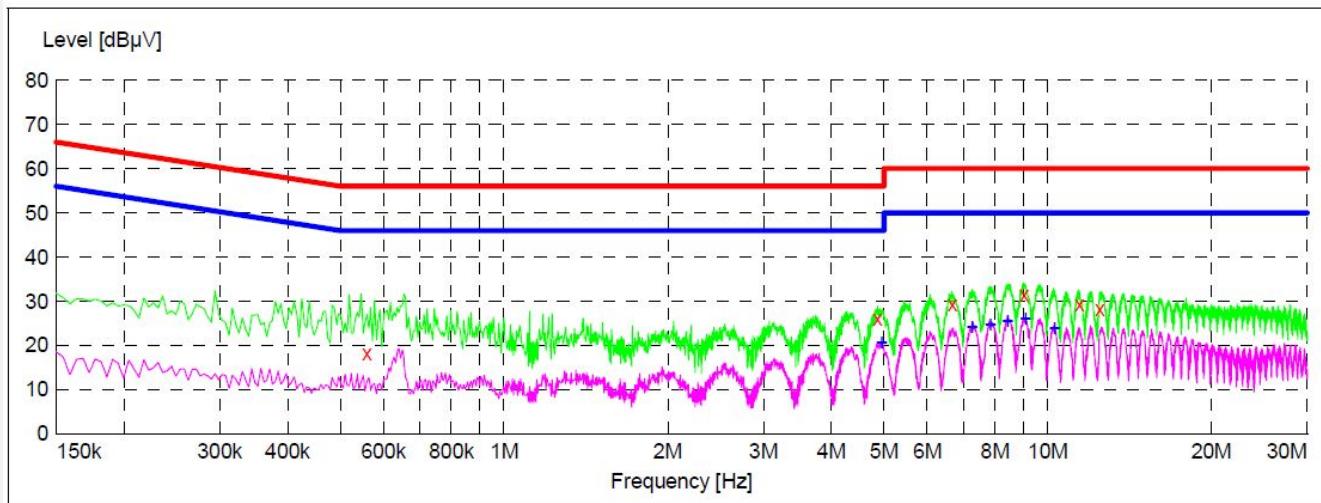
Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.204000	16.30	20.1	53	37.1	AV	N	GND
0.600000	23.20	20.1	46	22.8	AV	N	GND
1.036000	14.60	20.2	46	31.4	AV	N	GND
4.798000	13.50	20.5	46	32.5	AV	N	GND
8.524000	15.70	20.6	50	34.3	AV	N	GND
23.396500	17.70	20.8	50	32.3	AV	N	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: BT Mode and Charging
 Test Specification: AC 240V, 60Hz for adapter
 Comment: Live Line
 Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.559500	18.30	20.1	56	37.7	QP	L1	GND
4.856500	26.10	20.5	56	29.9	QP	L1	GND
6.683500	29.30	20.5	60	30.7	QP	L1	GND
9.046000	31.60	20.6	60	28.4	QP	L1	GND
11.444500	29.20	20.6	60	30.8	QP	L1	GND
12.466000	28.20	20.7	60	31.8	QP	L1	GND

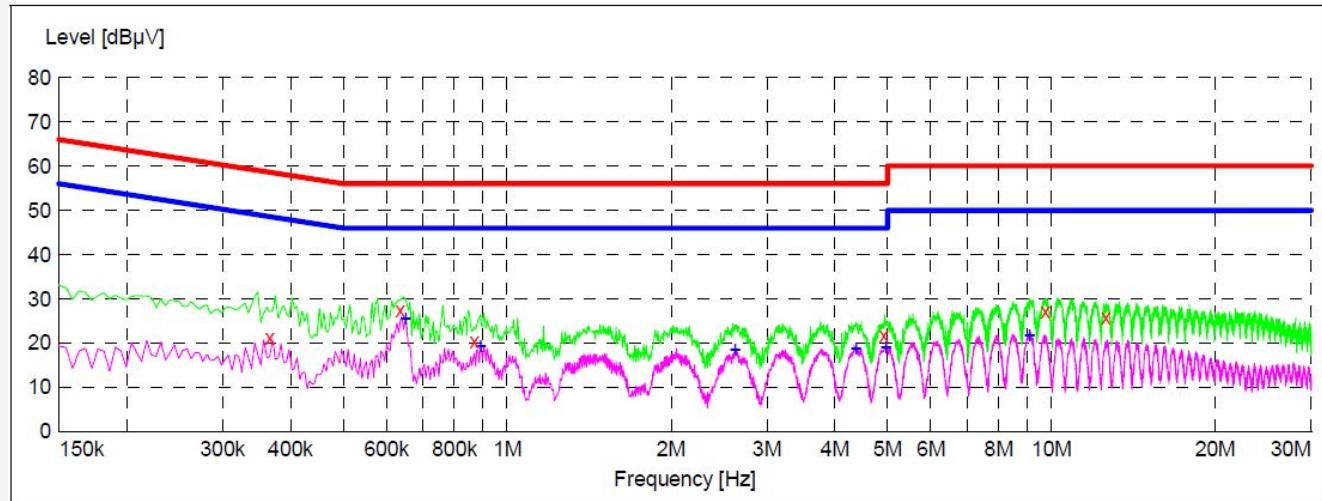
Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
4.946500	20.60	20.5	46	25.4	AV	L1	GND
7.250500	24.20	20.5	50	25.8	AV	L1	GND
7.831000	24.70	20.5	50	25.3	AV	L1	GND
8.429500	25.60	20.6	50	24.4	AV	L1	GND
9.095500	26.00	20.6	50	24.0	AV	L1	GND
10.283500	23.90	20.6	50	26.1	AV	L1	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: BT Mode and Charging
 Test Specification: AC 240V, 60Hz for adapter
 Comment: Neutral Line
 Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.366000	21.20	20.1	59	37.4	QP	N	GND
0.636000	27.40	20.1	56	28.6	QP	N	GND
0.870000	20.30	20.1	56	35.7	QP	N	GND
4.919500	21.70	20.5	56	34.3	QP	N	GND
9.734500	27.20	20.6	60	32.8	QP	N	GND
12.601000	25.80	20.7	60	34.2	QP	N	GND

Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.649500	25.40	20.1	46	20.6	AV	N	GND
0.892500	19.30	20.1	46	26.7	AV	N	GND
2.620000	18.50	20.4	46	27.5	AV	N	GND
4.375000	18.70	20.5	46	27.3	AV	N	GND
4.964500	19.20	20.5	46	26.8	AV	N	GND
9.118000	21.60	20.6	50	28.4	AV	N	GND

4. Radiation Interference

4.1 Requirements (15.247, 15.209):

4.1.1. Test Limits (< 30 MHZ)

Frequency (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meter)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30

4.1.2. Test Limits (\geq 30 MHZ)

FIELD STRENGTH of Fundamental: @3M	FIELD STRENGTH of Harmonics	S15.209 30 - 88 MHz	40 dB μ V/m
902-928 MHZ		88 - 216 MHz	43.5
2.4-2.4835 GHz		216 - 960 MHz	46
94 dB μ V/m @3m	54 dB μ V/m @3m	ABOVE 960 MHz	54dB μ V/m

For range 9KHz~30MHz, The measured value is really too low to be recorded.

Emissions radiated outside of the specified frequency bands, except for harmonics, shall be attenuated by at least 50 dB below the level of the fundamental or to the general radiated emission limits in 15.209, whichever is the lesser attenuation.

4.2 Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For 30MHz to 1000MHz:

Set the spectrum analyzer as:

RBW = 100kHz, VBW =300kHz,

Detector= Quasi-Peak

Trace mode= Max hold.

Sweep- auto couple.

For Above 1GHz:

Set the spectrum analyzer as:

RBW = 1MHz, VBW =3MHz,

Detector= Peak

Trace mode= Max hold.
Sweep- auto couple.

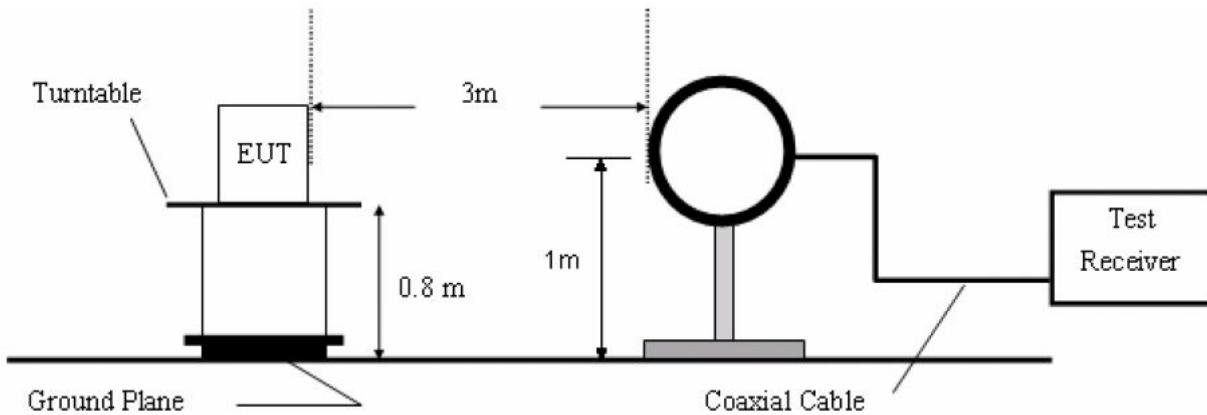
Set the spectrum analyzer as:
RBW =1MHz, VBW =10Hz
Detector= Average
Trace mode= Max hold.
Sweep- auto couple.

Test Equipment

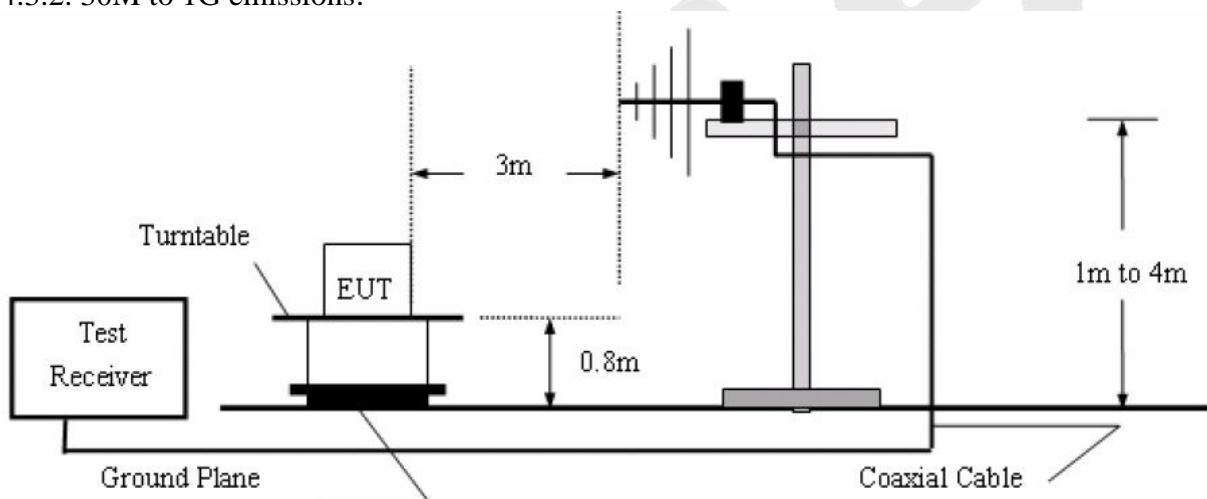
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analysis	Agilent	E4407B	US39390582	Apr. 17, 2015	1 Year
2.	Preamplifier	Instruments corporation	EMC011830	980100	Apr. 17, 2015	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Apr. 17, 2015	1 Year
4.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Apr. 20, 2015	1 Year
5.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Apr. 20, 2015	1 Year
6.	Pre-amplifier	SONOMA	310N	186860	Apr. 17, 2015	1 Year
7.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
8	Power Sensor	DAER	RPR3006 W	15I00041SN046	Jun 30, 2015	1 Year
9	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Jun 30, 2015	1 Year
10	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Jun 30, 2015	1 Year
11	Signal Generator	Agilent	E4421B	MY41000743	Jun 30, 2015	1 Year
12	DC Power supply	IV	IV-8080	YQSB0096	Jun 30, 2015	1 Year
13	TEMP&HUMI PROGRAMMABLE CHAMBER	Bell Group	BE-THK-150M8	SE-0137	Mar 16, 2015	1 Year

4.3 Test Configuration

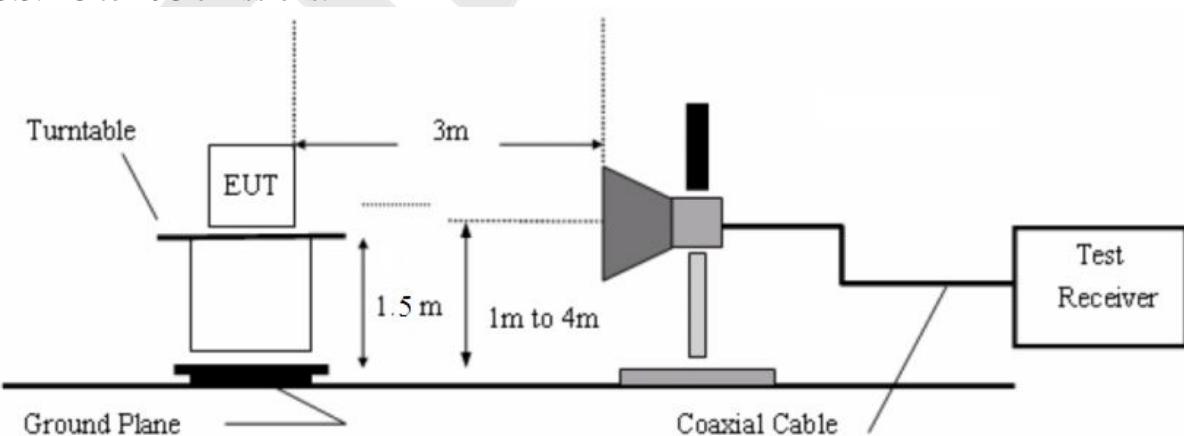
4.3.1. 9k to 30MHz emissions:



4.3.2. 30M to 1G emissions:



4.3.3. 1G to 40G emissions:

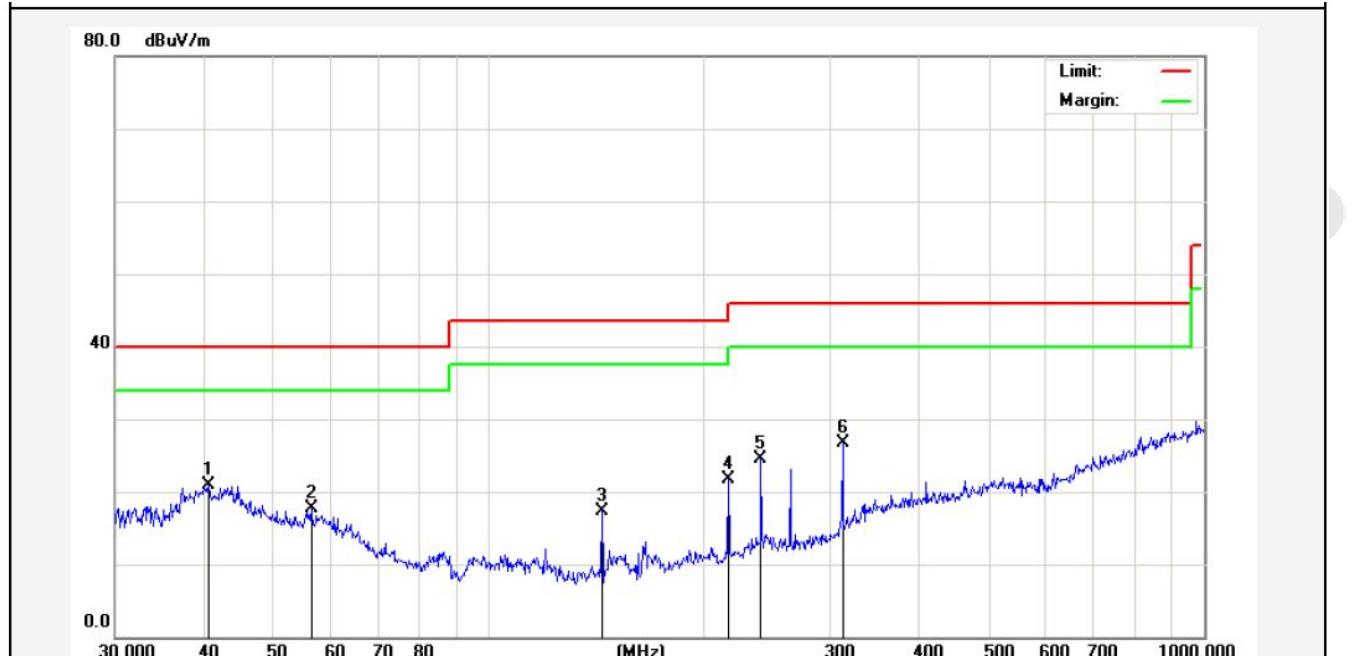


4.4 Test Results

PASS.

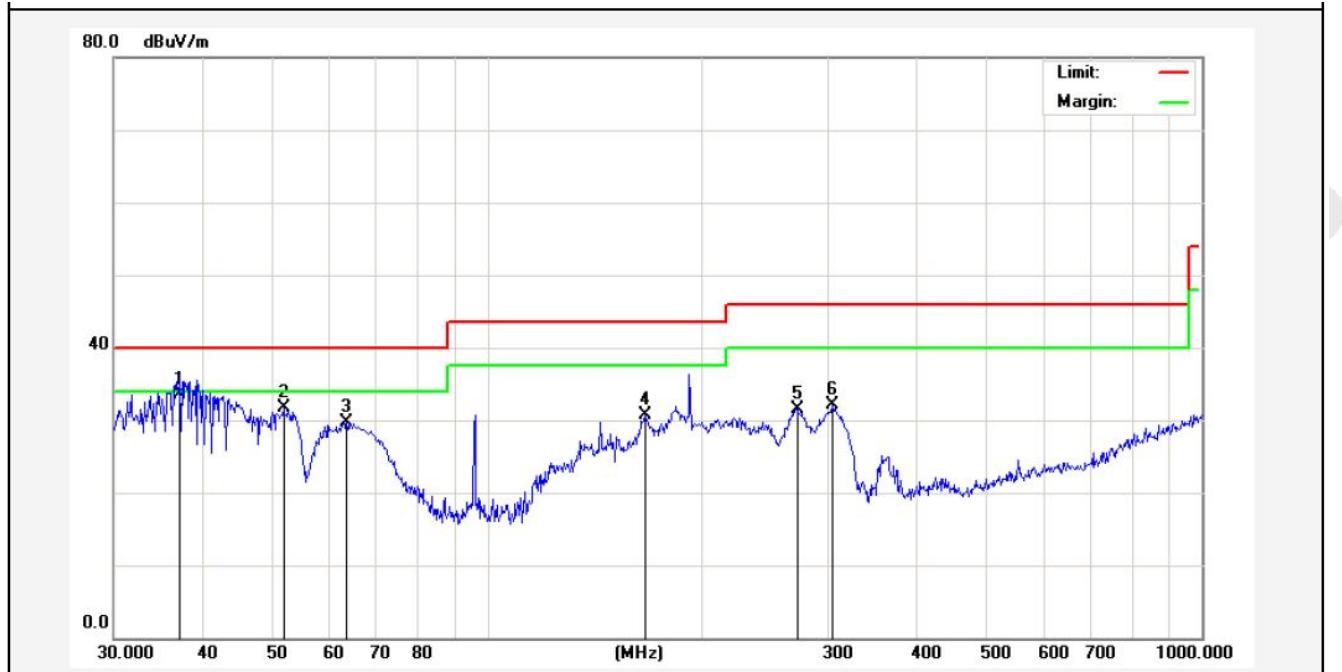
Please refer the following pages. Only the worst case (x orientation).

Job No.:	011508392I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C _3m	Power Source:	AC 120V, 60Hz for adapter
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	BT Mode and Charging	Distance:	3m



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	40.5591	31.49	-10.58	20.91	40.00	-19.09	peak			
2	56.3948	32.68	-15.05	17.63	40.00	-22.37	peak			
3	143.8295	40.64	-23.43	17.21	43.50	-26.29	peak			
4	216.0240	41.95	-20.27	21.68	46.00	-24.32	peak			
5	239.9874	42.69	-18.09	24.60	46.00	-21.40	peak			
6	312.1794	42.89	-16.21	26.68	46.00	-19.32	peak			

Job No.:	011508392I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C _3m	Power Source:	AC 120V, 60Hz for adapter
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	BT Mode and Charging	Distance:	3m



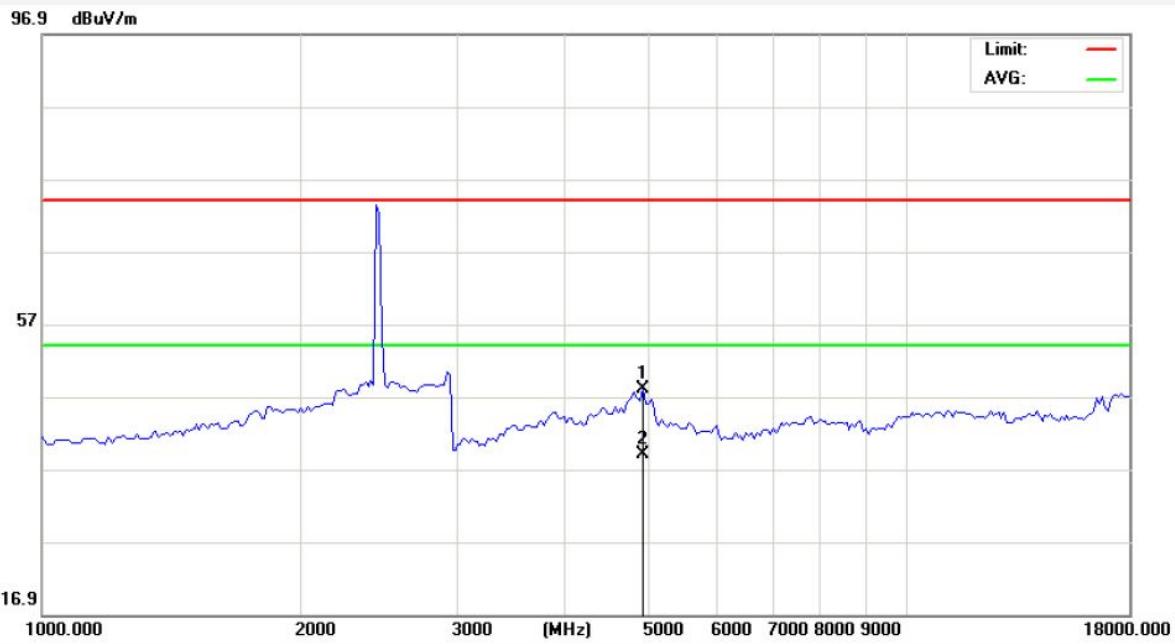
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	37.1550	46.19	-12.60	33.59	40.00	-6.41	QP	100	0	
2	51.8430	46.41	-14.70	31.71	40.00	-8.29	peak			
3	63.5356	46.57	-16.86	29.71	40.00	-10.29	peak			
4	166.0680	48.39	-17.68	30.71	43.50	-12.79	peak			
5	271.3246	46.16	-14.69	31.47	46.00	-14.53	peak			
6	303.5437	46.64	-14.61	32.03	46.00	-13.97	peak			

Job No.:	011508392I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2402 MHz)	Distance:	3m

No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	6397.500	37.22	7.50	44.72	74.00	-29.28	peak			
2	6397.500	26.55	7.50	34.05	54.00	-19.95	Avg			

Job No.:	011508392I		Polarization:	Vertical						
Standard:	(RE)FCC PART 15C_Class B_3m		Power Source:	DC 3.7V						
Test item:	Radiation Test (Above 1GHz)		Temp.(C)/Hum.(%RH):	24.3(C)/55%RH						
Test Mode:	TX(2402 MHz)		Distance:	3m						
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	5082.657	40.31	3.71	44.02	74.00	-29.98	peak			
2	5082.657	30.43	3.71	34.14	54.00	-19.86	Avg			

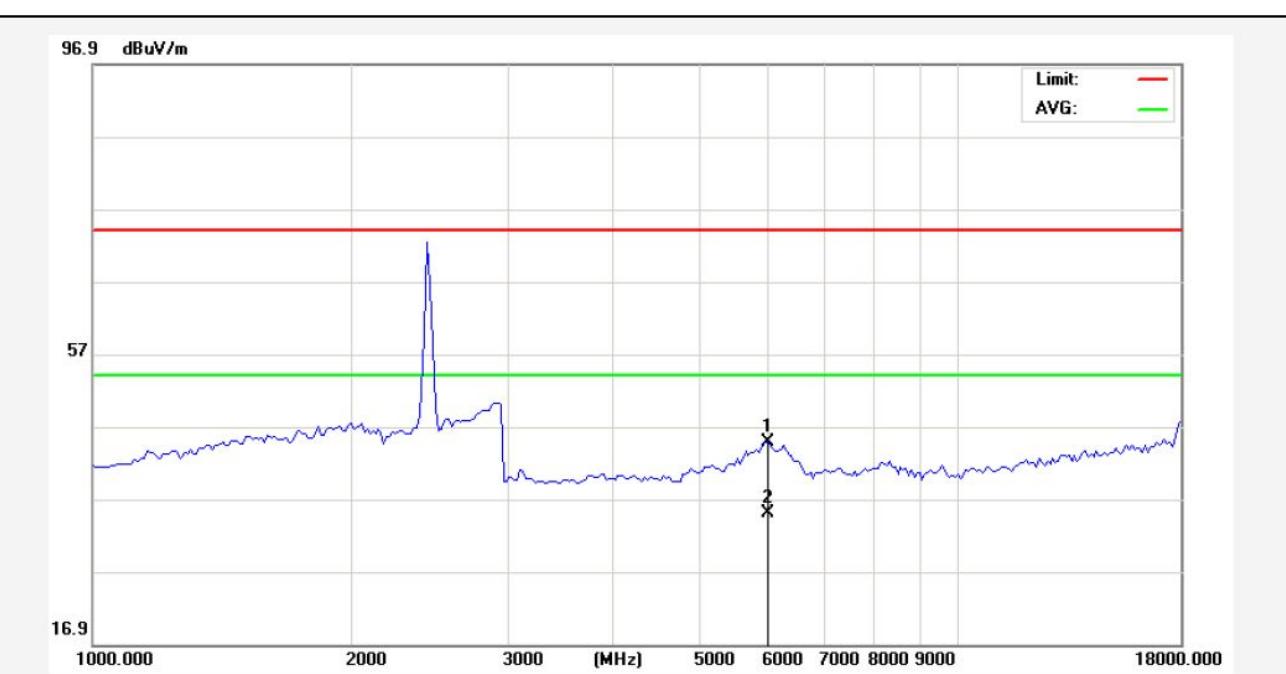
Job No.:	011508392I		Polarization:	Horizontal						
Standard:	(RE)FCC PART 15C_Class B_3m		Power Source:	DC 3.7V						
Test item:	Radiation Test (Above 1GHz)		Temp.(C)/Hum.(%RH):	24.3(C)/55%RH						
Test Mode:	TX(2441 MHz)		Distance:	3m						
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	5463.521	40.40	3.97	44.37	74.00	-29.63	peak			
2	5463.521	30.95	3.97	34.92	54.00	-19.08	Avg			

Job No.:	011508392I		Polarization:	Vertical						
Standard:	(RE)FCC PART 15C_Class B_3m		Power Source:	DC 3.7V						
Test item:	Radiation Test (Above 1GHz)		Temp.(C)/Hum.(%RH):	24.3(C)/55%RH						
Test Mode:	TX(2441 MHz)		Distance:	3m						
										
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	4952.500	44.49	3.57	48.06	74.00	-25.94	peak			
2	4952.500	35.39	3.57	38.96	54.00	-15.04	Avg			

Job No.:	011508392I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2480 MHz)	Distance:	3m

No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	5887.500	40.33	6.43	46.76	74.00	-27.24	peak			
2	5887.500	30.17	6.43	36.60	54.00	-17.40	AVG			

Job No.:	011508392I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2480 MHz)	Distance:	3m



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	6015.000	37.62	7.14	44.76	74.00	-29.24	peak			
2	6015.000	27.77	7.14	34.91	54.00	-19.09	Avg			

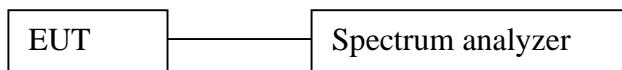
5. CHANNEL SEPARATION TEST

5.1 Measurement Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

1. Span= Wide enough to capture the peaks of two adjacent channels
2. Set the RBW = 30 kHz.
3. Set the VBW = 100 kHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

5.2 Test SET-UP



5.3 Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analysis	Agilent	E4407B	US39390582	Apr. 17, 2015	1 Year
2.	Preamplifier	Instruments corporation	EMC011830	980100	Apr. 17, 2015	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Apr. 17, 2015	1 Year
4.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Apr. 20, 2015	1 Year
5.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB9163-289	Apr. 20, 2015	1 Year
6.	Pre-amplifier	SONOMA	310N	186860	Apr. 17, 2015	1 Year
7.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
8	Power Sensor	DAER	RPR3006W	15I00041SN046	Jun 30, 2015	1 Year
9	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Jun 30, 2015	1 Year
10	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Jun 30, 2015	1 Year
11	Signal Generator	Agilent	E4421B	MY41000743	Jun 30, 2015	1 Year
12	DC Power supply	IV	IV-8080	YQSB0096	Jun 30, 2015	1 Year
13	TEMP&HUMI PROGRAMMABLE CHAMBER	Bell Group	BE-THK-150M8	SE-0137	Mar 16, 2015	1 Year

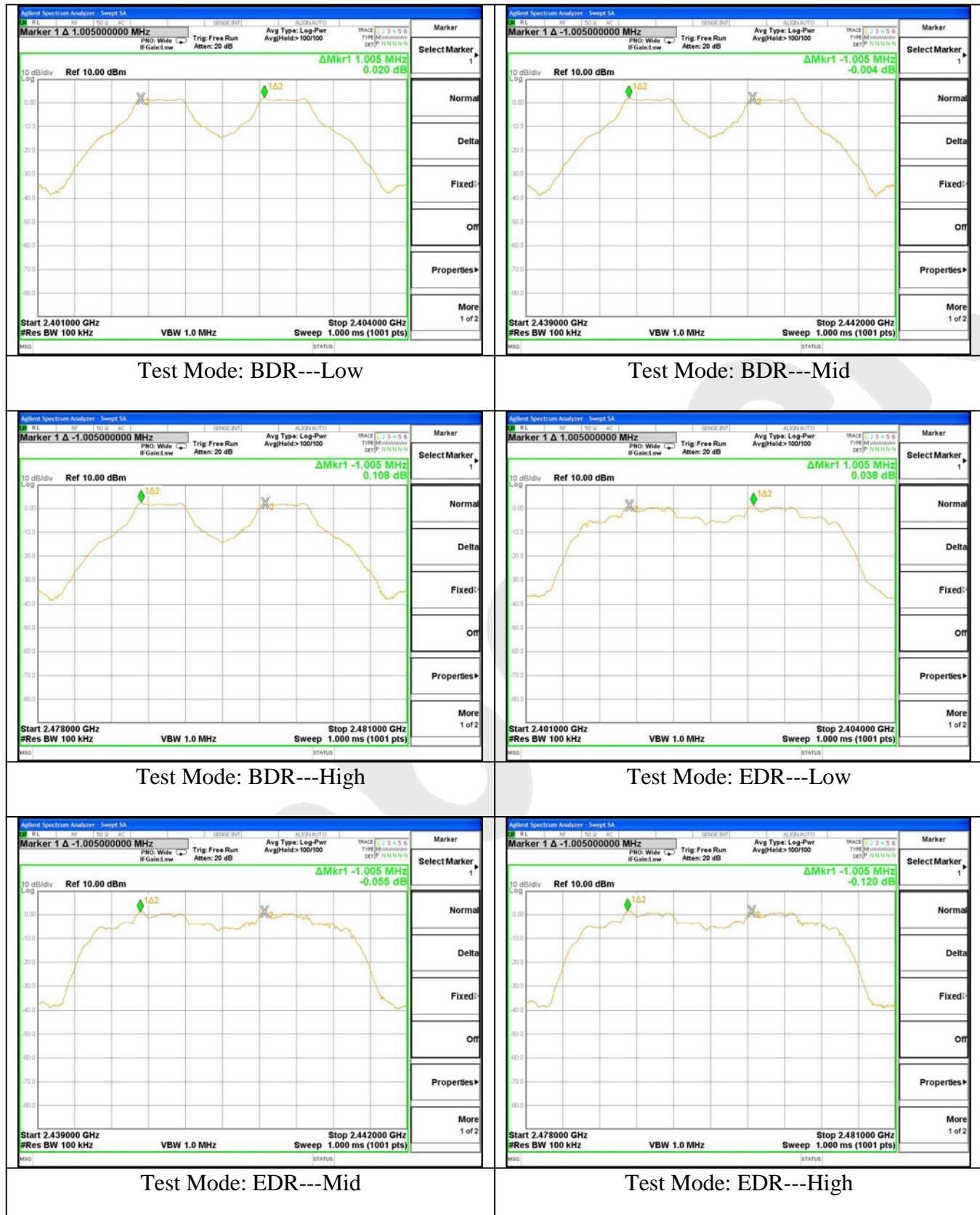
5.4 Test Results

Test Item	: Frequency Separation	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 3.7V	Temperature	: 24°C
Test Result	: PASS	Humidity	: 55%RH

Channel	Frequency (MHz)	Separation Read Value (kHz)	Limit (kHz)	Modulation Mode
Low	2401	1005	927.6	BDR
Mid	2441	1005	930.7	BDR
High	2480	1005	930.8	BDR
Low	2401	1005	843.3	EDR
Mid	2441	1005	842.7	EDR
High	2480	1005	842.0	EDR

Remark:

1. The limit of mode (EDR) is 2/3 of 20dB BW;



6. 20DB BANDWIDTH TEST

6.1 Measurement Procedure

Using the following spectrum analyzer settings:

1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
2. Set the RBW = 30 kHz.
3. Set the VBW = 100 kHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

6.2 Test SET-UP



6.3 Test Equipment

Same as the equipment listed in 5.3.

6.4 Test Results

Test Item	:	20dB BW	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V	Temperature	:	24°C
Test Result	:	PASS	Humidity	:	55%RH

Channel	Frequency (MHz)	20dB Down BW(kHz)	Modulation Mode
Low	2401	927.6	BDR
Mid	2441	930.7	BDR
High	2480	930.8	BDR
Low	2401	1265.0	EDR
Mid	2441	1264.0	EDR
High	2480	1263.0	EDR



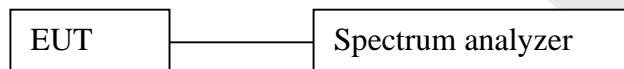
7. QUANTITY OF HOPPING CHANNEL TEST

7.1 Measurement Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

1. Span= the frequency band of operation
2. Set the RBW = 1 MHz.
3. Set the VBW = 1 MHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

7.2 Test SET-UP



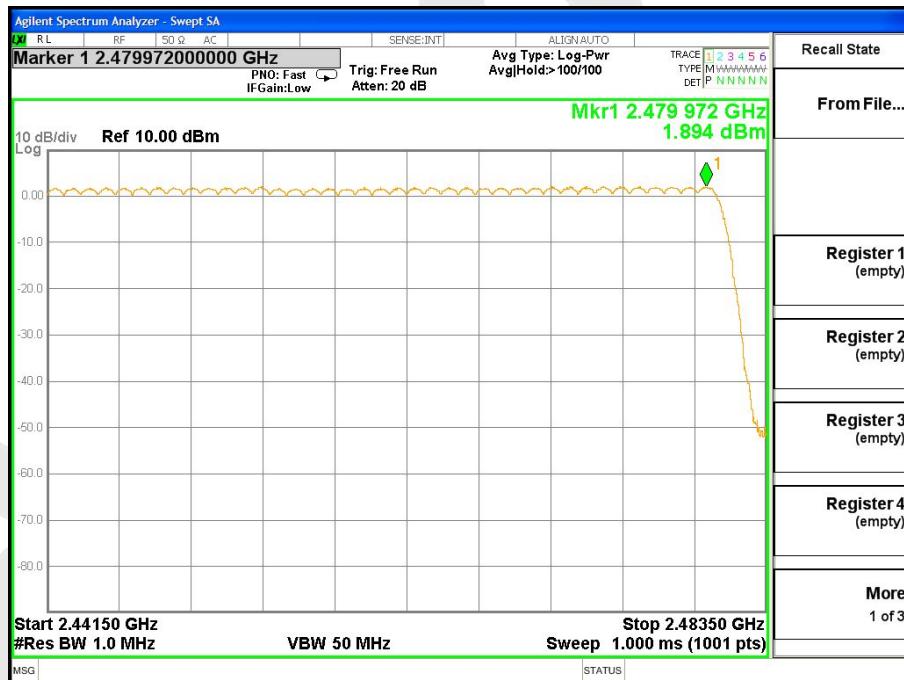
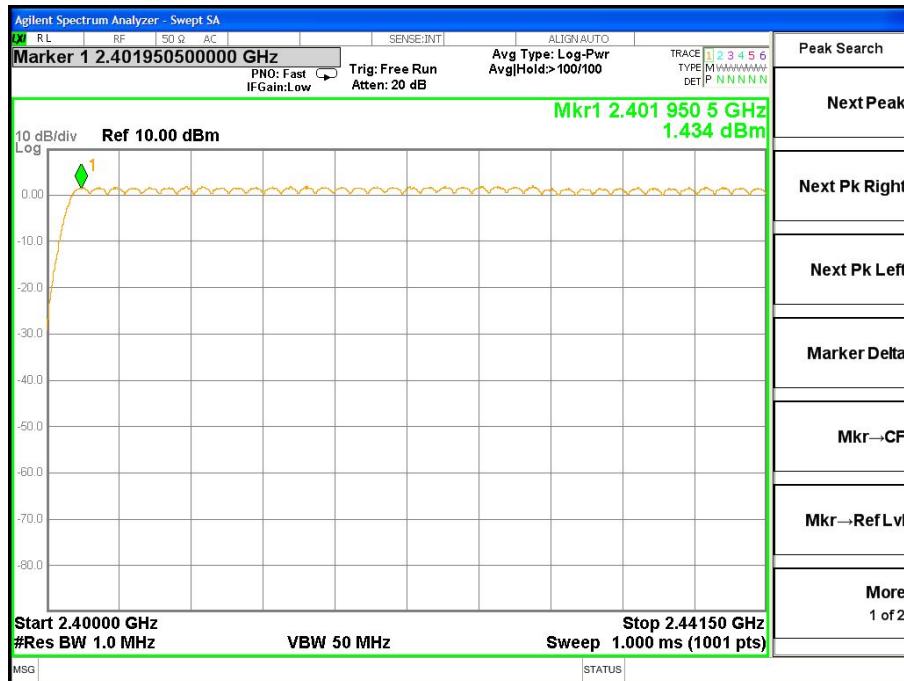
7.3 Test Equipment

Same as the equipment listed in 5.3.

7.4 Test Results

Test Item	: Number of Hopping Frequency	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 3.7V	Temperature	: 24 °C
Test Result	: PASS	Humidity	: 55%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel
2402-2480	79	>15



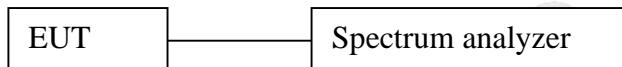
8. DWELL TIME TEST

8.1 Measurement Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span= zero span, centered on a hopping channel
2. Set the RBW = 1 MHz.
3. Set the VBW = 1 MHz.
4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

8.2 Test SET-UP



8.3 Test Equipment

Same as the equipment listed in 5.3.

8.4 Test Results

Test Item	:	Time of Occupancy	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V	Temperature	:	24°C
Test Result	:	PASS	Humidity	:	55%RH

Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)
DH1	0.366	time slot length *1600/2 /79 * 31.6	117.12	0.4
DH3	1.608	time slot length *1600/4 /79 * 31.6	257.28	0.4
DH5	2.870	time slot length *1600/6 /79 * 31.6	306.13	0.4



9. MAXIMUM PEAK OUTPUT POWER TEST

9.1 Measurement Procedure

- a. Check the calibration of the measuring instrument(SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. The center frequency of the spectrum analyzer is set to the fundamental frequency and using proper RBW and VBW setting.
- d. Measure the captured power within the band and recording the plot.
- e. Repeat above procedures until all frequencies required were complete.

Using the following spectrum analyzer settings:

1. Span= approximately 5 times the 20dB bandwidth, centered on a hopping channel
2. Set the RBW = 3 MHz.
3. Set the VBW = 3 MHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

9.2 Test SET-UP



9.3 Test Equipment

Same as the equipment listed in 5.3.

9.4 Test Results

Test Item : Max. peak output power Test Mode : CH Low ~ CH High
Test Voltage : DC 3.7V Temperature : 24°C
Test Result : PASS Humidity : 55%RH

Channel Frequency (MHz)	Peak Power output(mW)	Peak Power output(dBm)	Peak Power Limit(mW)	Results	Modulation
2402	1.522	1.825	1000	PASS	BDR
2441	1.620	2.094	1000	PASS	BDR
2480	1.772	2.484	1000	PASS	BDR
2402	1.496	1.748	125	PASS	EDR
2441	1.430	1.553	125	PASS	EDR
2480	1.569	1.956	125	PASS	EDR



10. BAND EDGE TEST

10.1 Measurement Procedure

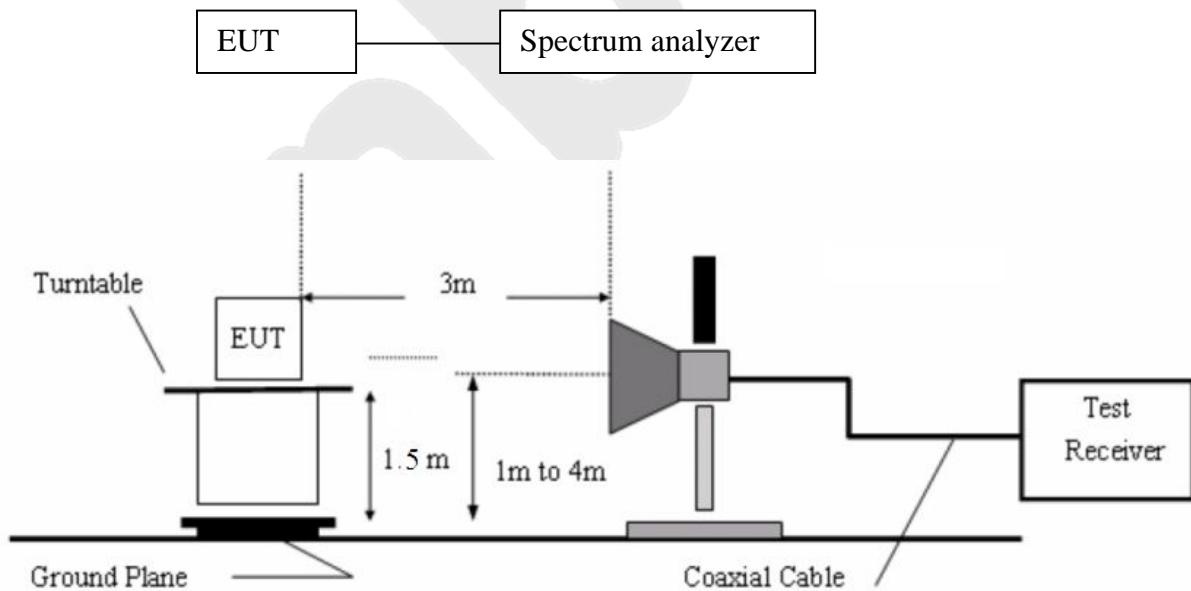
A) Conducted Emission method:

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Put it on the Rotated table and turn on the EUT and make it operate in transmitting mode. Then set it to low Channel and High Channel within its operating range, and make sure the instrument is operated in its linear range.
3. Set both RBW and VBW of spectrum analyzer to 100kHz with a convenient frequency span including 100kHz bandwidth from band edge,
4. Measurement the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Report above procedures until all measured frequencies were complete.

B) Radiated Emission method:

The EUT is placed on a turn table which is 1.5 meter high above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. for Radiated emissions restricted band RBW= 1 MHz, VBW= 3 MHz.

10.2 Test SET-UP



10.3 Test Equipment

Same as the equipment listed in 5.3.

10.4 Test Results

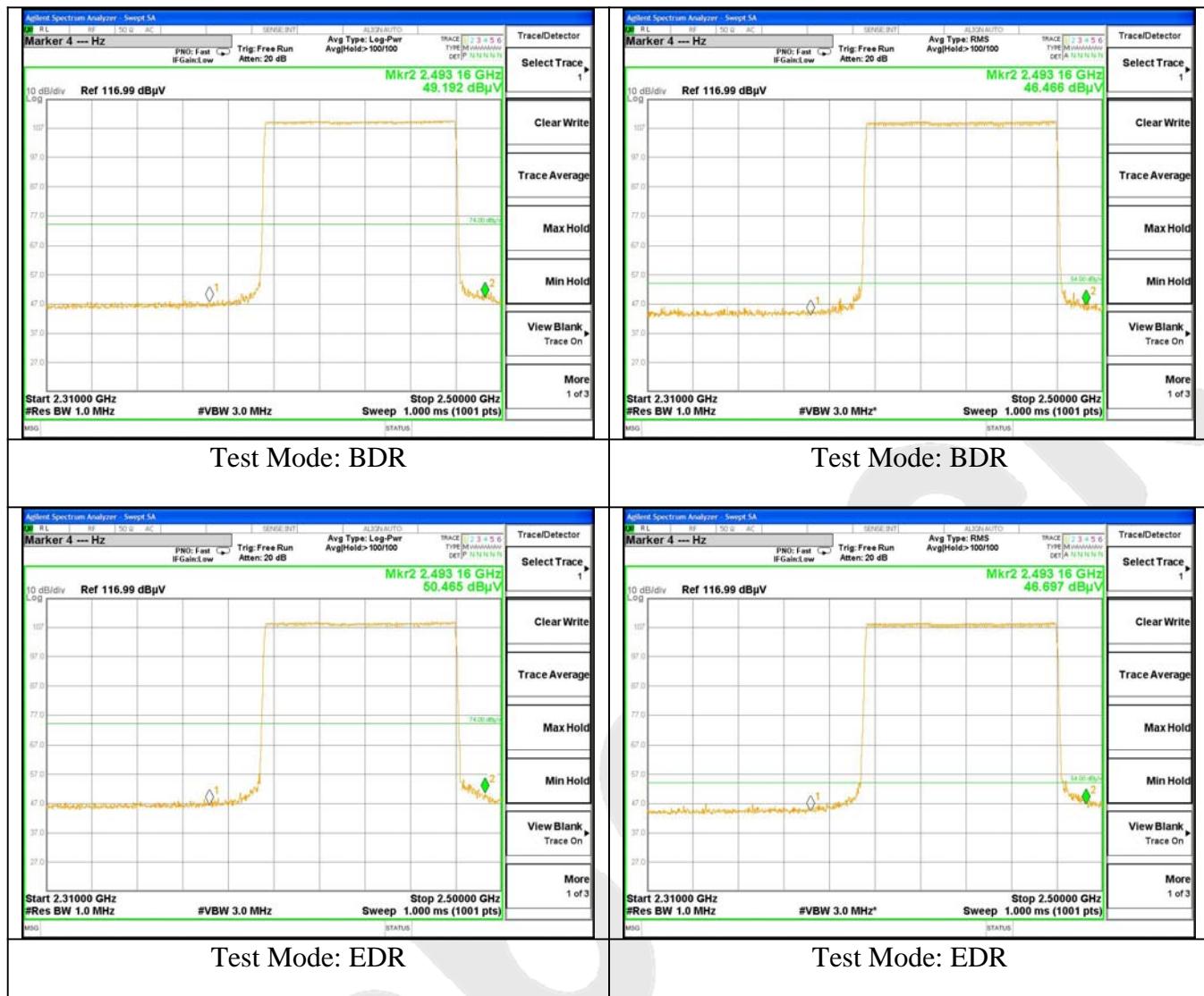
Pass.

Please refer the following data.

Test Item : Band eadge
Test Voltage : DC 3.7V
Test Result : PASS

Test Mode : CH Low ~ CH High
Temperature : 24°C
Humidity : 55%RH

For Hopping Mode:



Test Item : Band edge
Test Voltage : DC 3.7V
Test Result : PASS

Test Mode : CH Low ~ CH High
Temperature : 24°C
Humidity : 55%RH

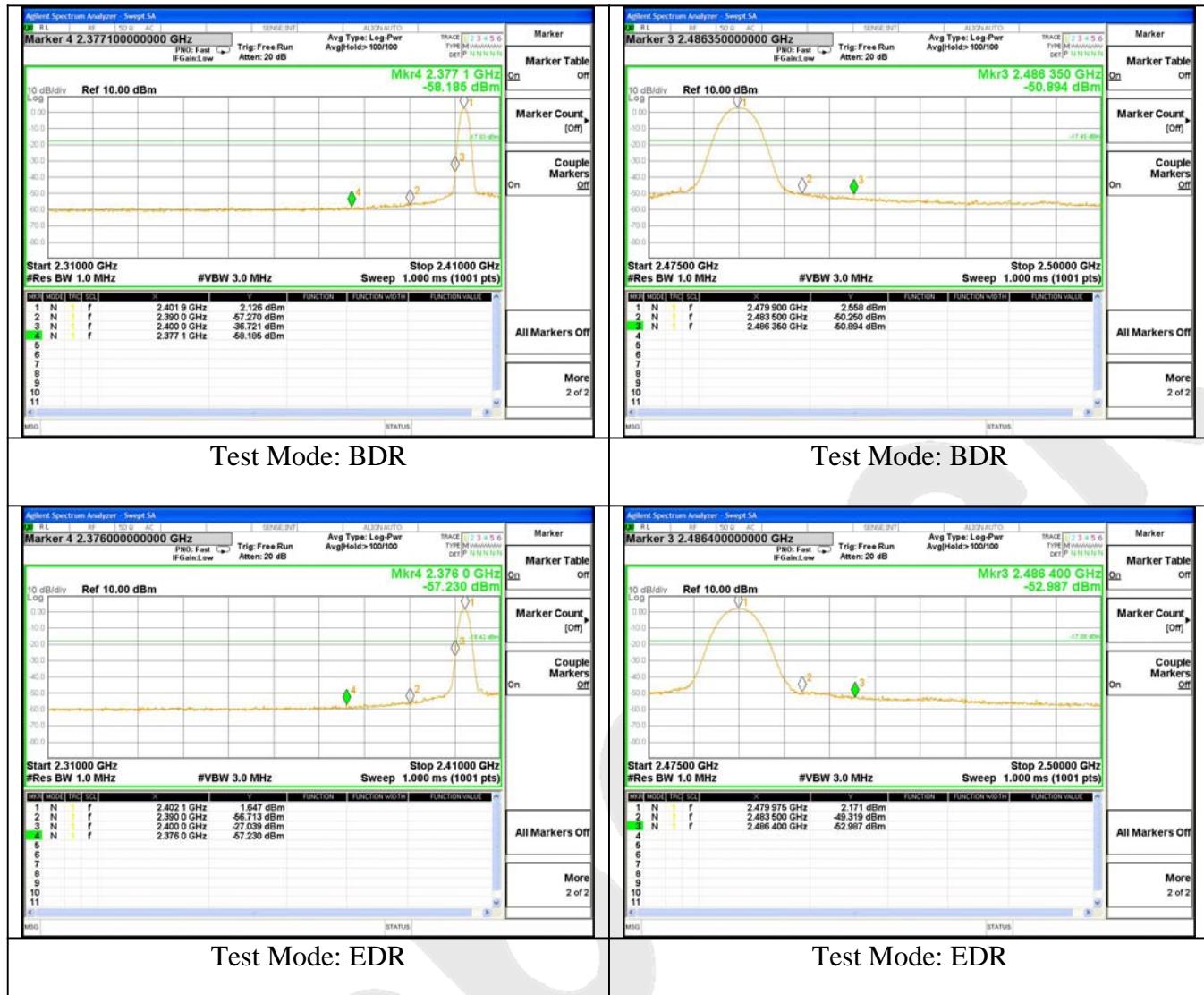
For Non-Hopping Mode:

1. Conducted Test

Frequency (MHz)	Peak Power Output(dBm)	Emission read Value(dBm)	Result of Band edge(dBc)	Band edge Limit(dBc)	Modulation
<2400	2.126	-36.721	38.847	>20dBc	BDR
	1.647	-27.039	28.686	>20dBc	EDR
>2483.5	2.558	-50.250	52.808	>20dBc	BDR
	2.171	-49.319	51.490	>20dBc	EDR

2. Radiated emission Test

Frequency (MHz)	Antenna polarization (H/V)	Emission (dB _{UV} /m)		Band edge Limit (dB _{UV} /m)		Modulation
		PK	AV	PK	AV	
<2400	V	56.25	37.48	74.00	54.00	BDR
	V	53.14	35.89	74.00	54.00	EDR
>2483.5	V	54.53	36.32	74.00	54.00	BDR
	V	52.34	34.91	74.00	54.00	EDR



11. ANTENNA APPLICATION

11.1 Antenna requirement

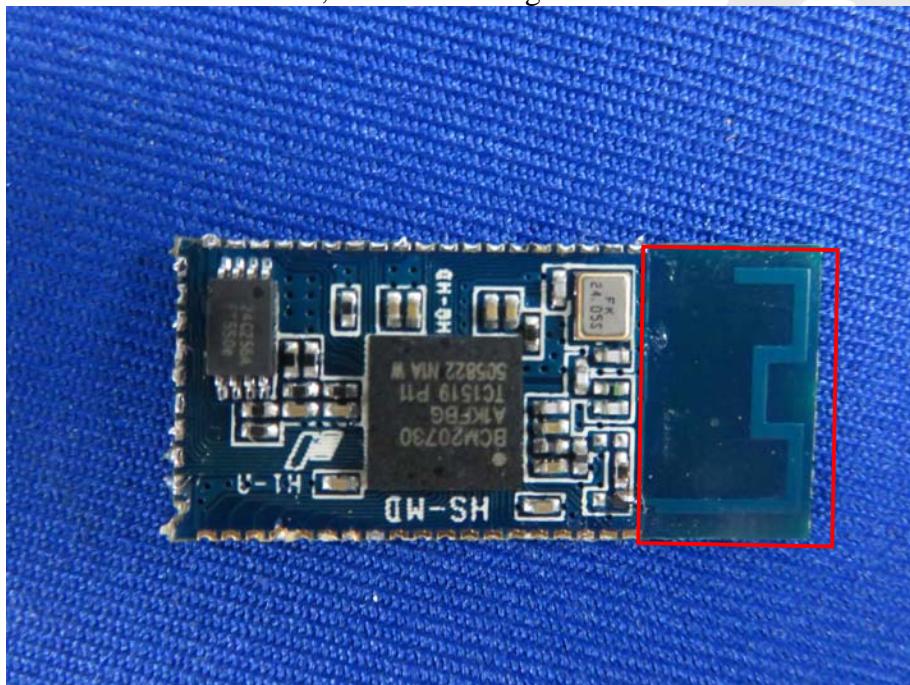
The EUT'S antenna is met the requirement of FCC part 15C section 15.203 and 15.247.

FCC part 15C section 15.247 requirements:

Systems operating in the 2402-2480MHz band that are used exclusively for fixed, point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum peak output power of the intentional radiator is reduced by 1dB for every 3dB that the directional gain of the antenna exceeds 6dBi.

11.2 Result

The EUT's antenna used a PCB Antenna, The antenna's gain is 1.87dBi and meets the requirement.

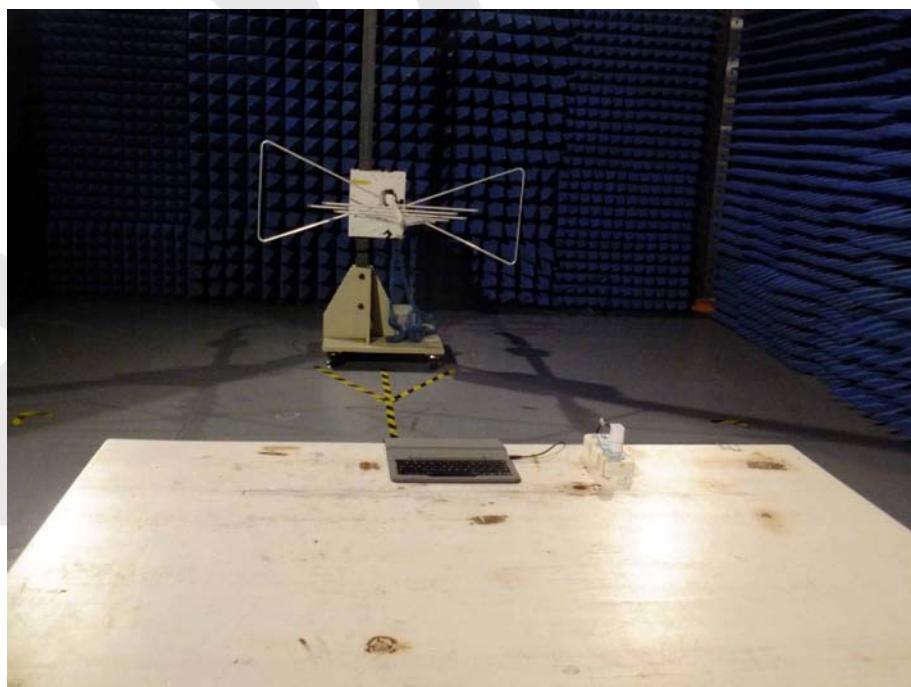


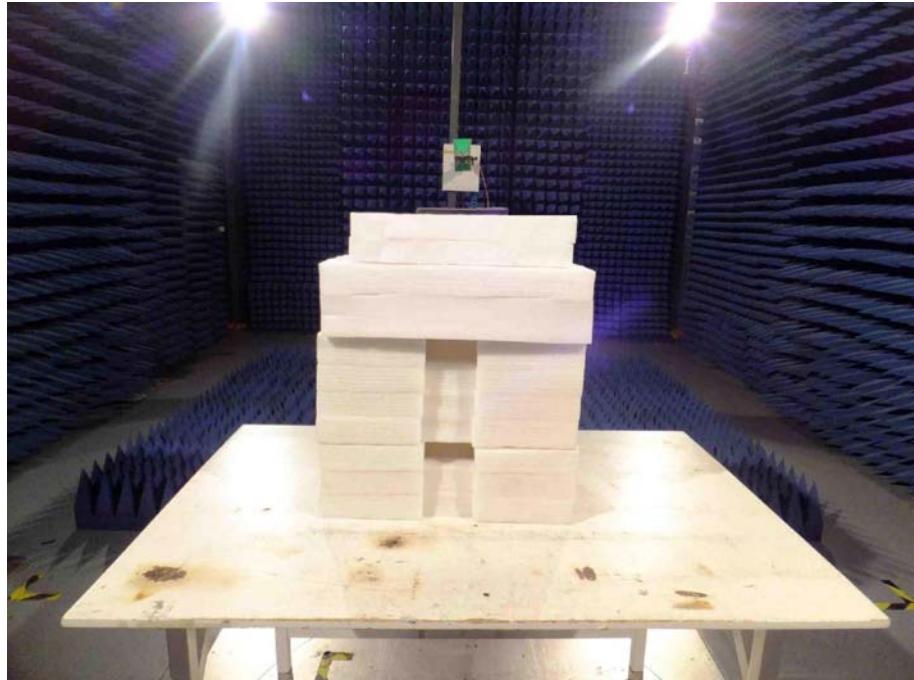
12. PHOTOGRAPH

12.1 Photo of Power Line Conducted Emission Measurement



12.2 Photo of Radiation Emission Test





APPENDIX I (EXTERNAL PHOTOS)

Figure 1
The EUT- Overall View

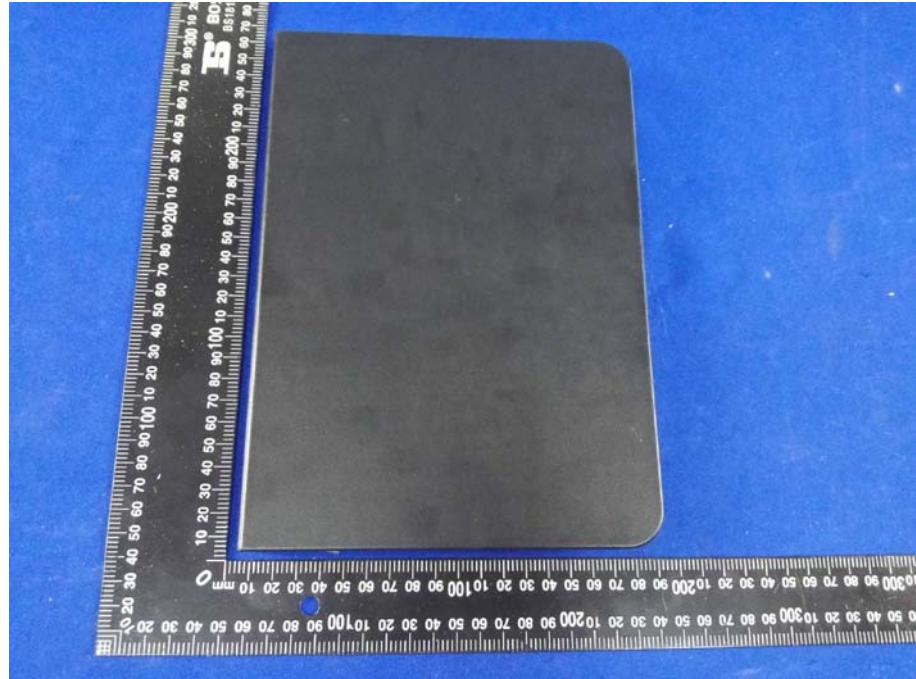


Figure 2
The EUT- Top View



Figure 3
The EUT- Bottom View



Figure 4
The EUT- Front View



Figure 5
The EUT- Back View

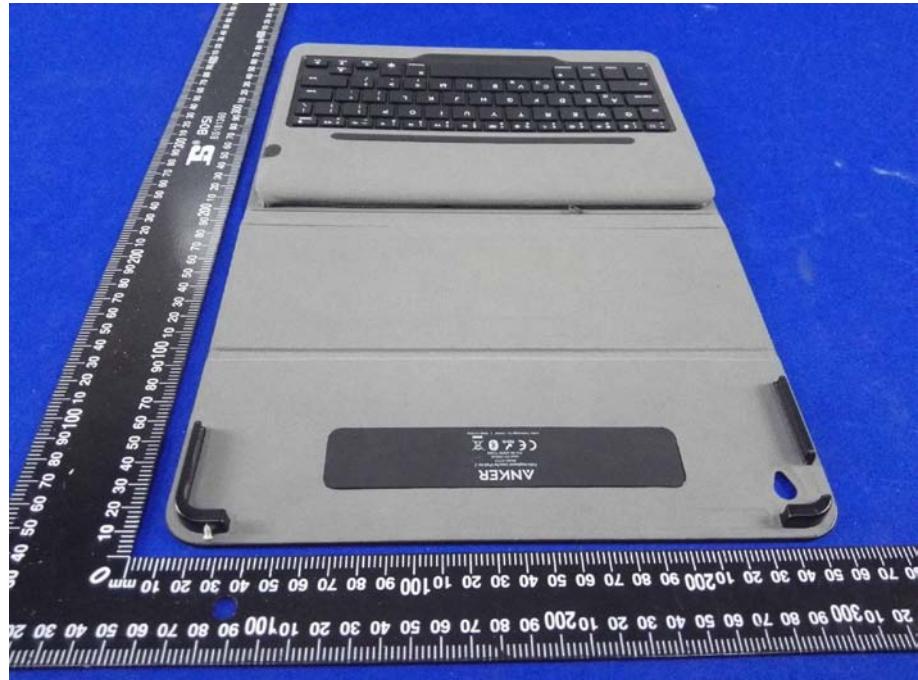


Figure 6
The EUT- Right View



Figure 7
The EUT- LeftView



APPENDIX II (INTERNAL PHOTOS)

Figure 8
The EUT-Inside View



Figure 9
PCB of the EUT-Front View

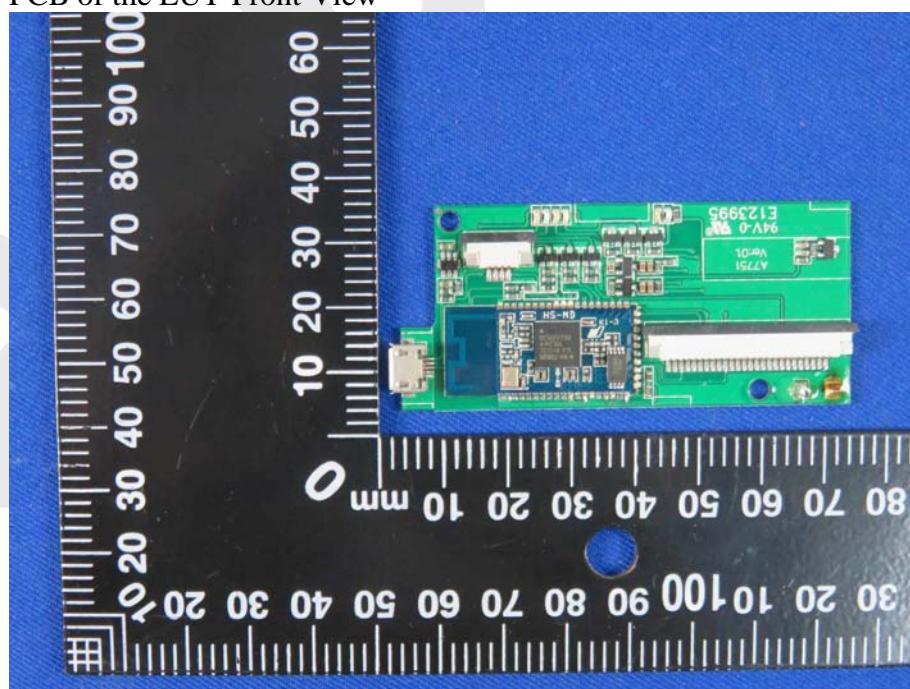


Figure 10
PCB of the EUT-Back View

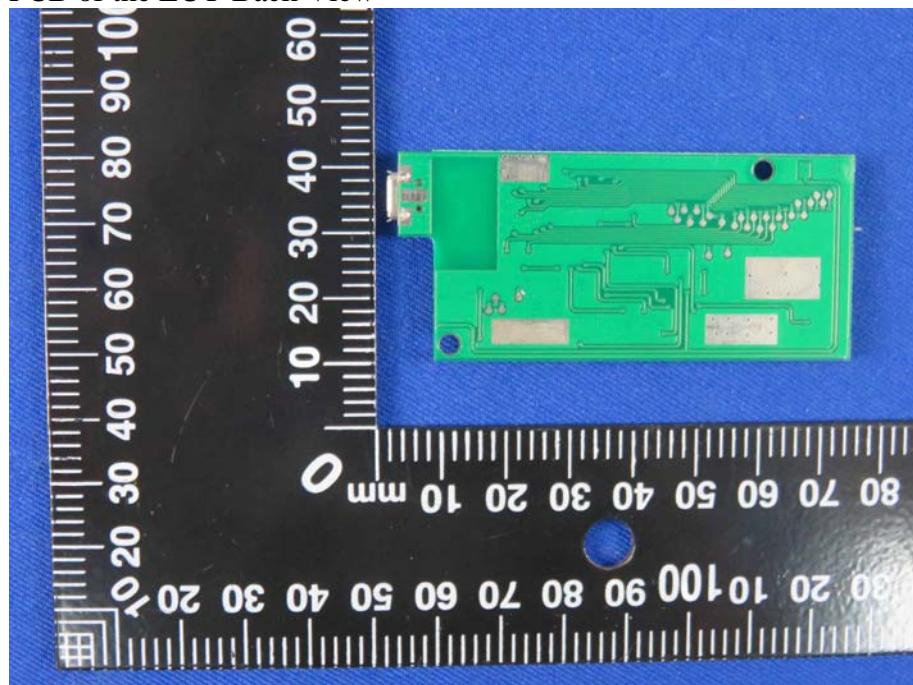


Figure 11
PCB of the EUT-Front View

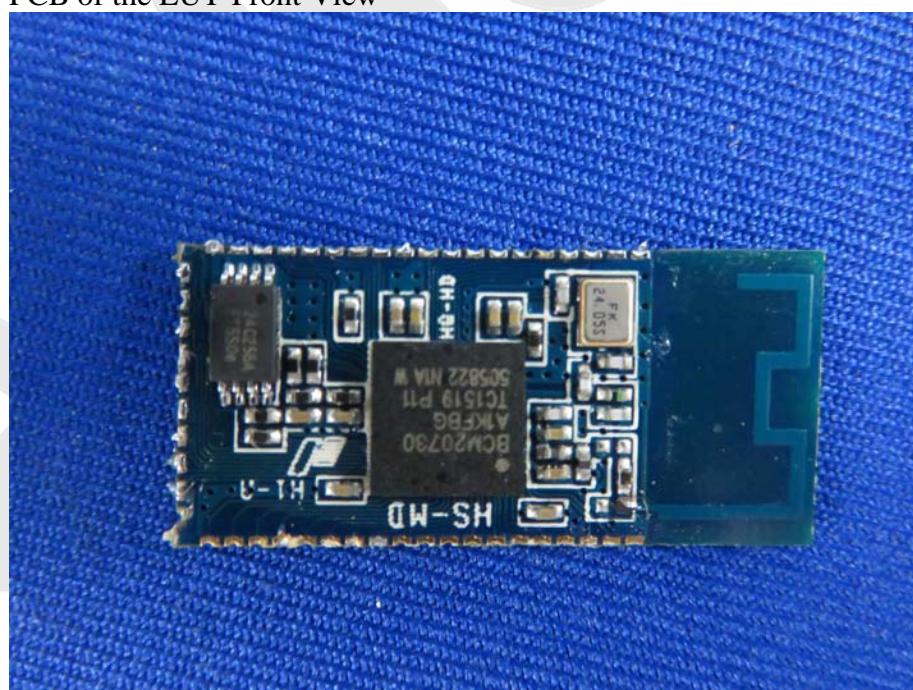
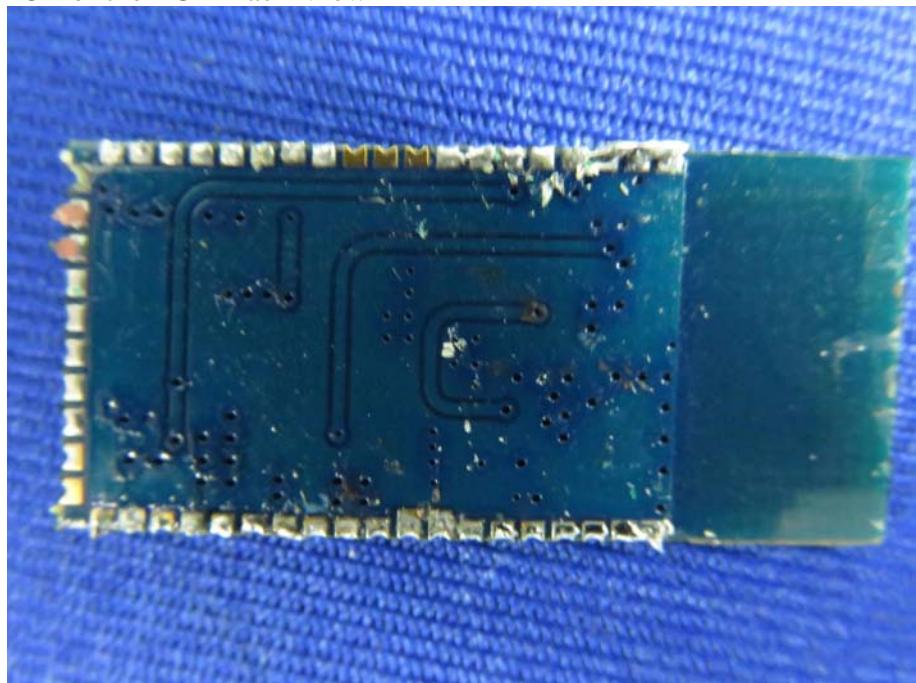


Figure 12
PCB of the EUT-Back View



Anbooo